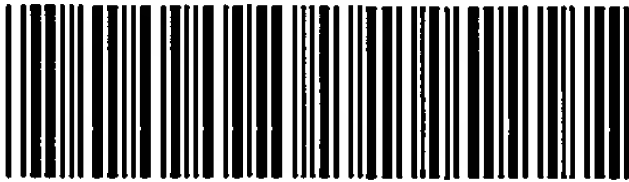


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/931,108	STEICHEN ET AL.	
	Examiner	Art Unit	
	Scott L. Jarrett	3623	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (JPO, EPO, US) keyword - see attached	8/16/2005	SJ
ProQuest see attached	8/16/2005	SJ
IEEE see attached	8/16/2005	SJ
Dialog see attached	8/16/2005	SJ